

July 2014

FDD8445

N-Channel PowerTrench® MOSFET 40V, 50A, 8.7m Ω

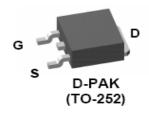
Features

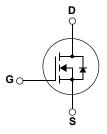
- $R_{DS(ON)}$ = 6.7 m Ω (Typ), V_{GS} = 10V, I_D =50A
- $Q_{g(10)} = 45nC$ (Typ), $V_{GS} = 10V$
- Low Miller Charge
- Low Qrr Body Diode
- UIS Capability (Single Pulse/ Repetitive Pulse)
- RoHS Compliant



Applications

- Powertrain Management
- Electronic Transmission
- Distributed Power Architecture and VRMs
- Primary Switch for 12V Systems





Absolute Maximum Ratings $T_c = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DSS}	Drain to Source Voltage	40	V
V_{GS}	Gate to Source Voltage	±20	V
	Drain Current Continuous (V _{GS} =10v) (Note 1)	70	Α
I_D	Continuous (V_{GS} =10v,with $R_{\theta JA}$ = 52°C/W)	15.2	Α
	Pulsed	Figure 4	
E _{AS}	SinglePulseAvalancheEnergy (Note2)	144	mJ
D	Power Dissipation	79	W
P_{D}	Derate above 25°C	0.53	W/°C
T _J , T _{STG}	Operating and Storage Temperature	-55 to +175	°C

Thermal Characteristics

ĺ	$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.9	°C/W
	$R_{\theta JA}$	Thermal Resistance, Junction to Ambient TO-252, lin ² copper pad area	52	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8445	FDD8445	TO-252AA	13"	12mm	2500 units

Electrical Characteristics T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
I	Zero Gate Voltage Drain Current	V _{DS} = 32V	-	-	1	μΑ
IDSS		$V_{GS} = 0V$ $T_J = 150$ °C	-	-	250	
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20V	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	2.8	4	V
		$I_D = 50A, V_{GS} = 10V$	-	6.7	8.7	
R _{DS(ON)}	Drain to Source On Resistance	$I_D = 50A$, $V_{GS} = 10V$, $T_{.1} = 175$ °C	-	12.5	16.3	mΩ

Dynamic Characteristics

-							
C _{ISS}	Input Capacitance	V 05V V 0V		-	3040	4050	pF
C _{OSS}	Output Capacitance	$V_{DS} = 25V, V_{GS}$ = f = 1MHz	$V_{DS} = 25V, V_{GS} = 0V,$		295	390	pF
C _{RSS}	Reverse Transfer Capacitance	1 - 1101112		-	178	270	pF
R_G	Gate Resistance	f = 1MHz		-	1.7	-	Ω
$Q_{g(TOT)}$	Total Gate Charge at 10V	V _{GS} = 0 to 10V		-	45	59	nC
Q _{g(5)}	Total Gate Charge at 5V	V _{GS} = 0 to 5V		-	17	22	nC
$Q_{g(TH)}$	Threshold Gate Charge	V _{GS} = 0 to 2V	V _{DD} =20V,	-	5.8	7.6	nC
Q _{gs}	Gate to Source Gate Charge		$I_{D} = 50A$	-	12.5	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau			-	9.5	-	nC
Q _{qd}	Gate to Drain "Miller" Charge			-	10.5	-	nC

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Switching	g Characteristics					
t _(on)	Turn-On Time		-	-	138	ns
t _{d(on)}	Turn-On Delay Time		-	10	-	ns
t _r	Turn-On Rise Time	$V_{DD} = 20V, I_{D} = 50A$ $V_{GS} = 10V, R_{GS} = 2\Omega$	-	82	-	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10V, R_{GS} = 2 Ω	-	26	-	ns
t _f	Turn-Off Fall Time		-	9.6	-	ns
t _{off}	Turn-Off Time		-	-	53	ns

Drain-Source Diode Characteristics

V	Source to Drain Diode Voltage	I _{SD} =50A	-	-	1.25	V
v_{SD}		I _{SD} =25A	-	1	1.0	V
t _{rr}	Reverse Recovery Time	I _F = 50A, dI _F /dt=100A/μs	-	-	39	ns
Q _{rr}	Reverse Recovery Charge	I _F = 50A, dI _F /dt=100A/μs	-	-	38	nC

Total Maximum package current capability is 50A.
2: Starting T_J = 25°C, L=0.18mH, I_{AS}=40A.

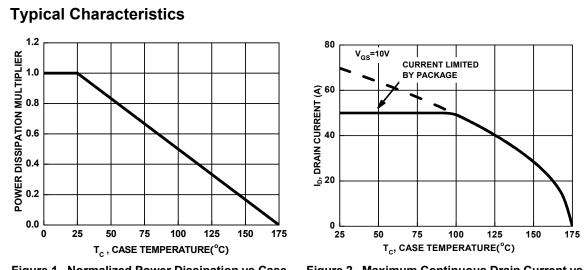


Figure 1. Normalized Power Dissipation vs Case Temperature

Figure 2. Maximum Continuous Drain Current vs Case Temperature

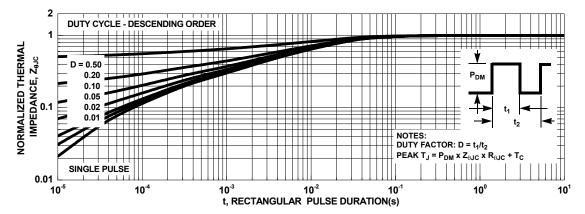


Figure 3. Normalized Maximum Transient Thermal Impedance

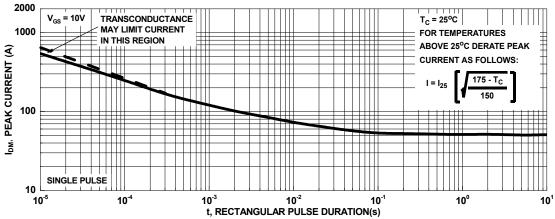
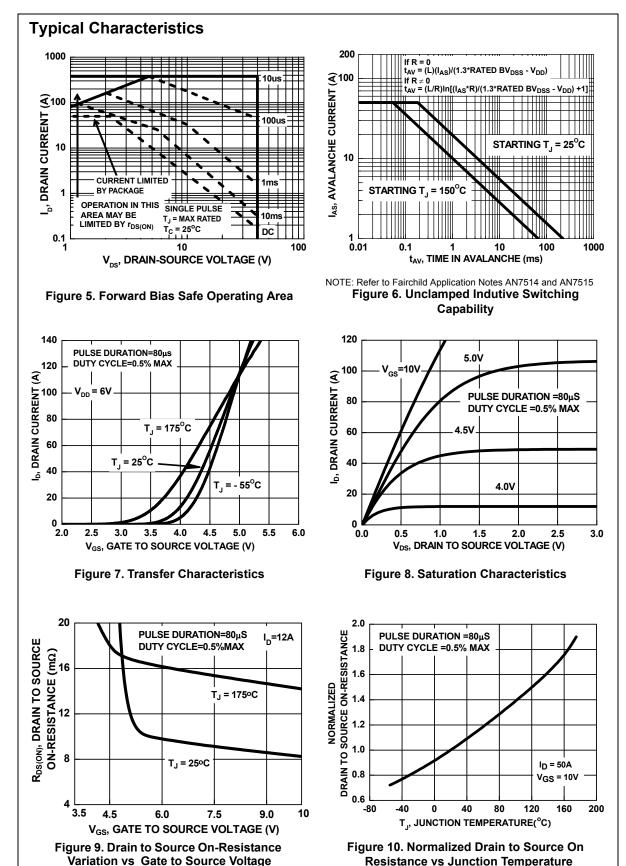


Figure 4. Peak Current Capability



Typical Characteristics

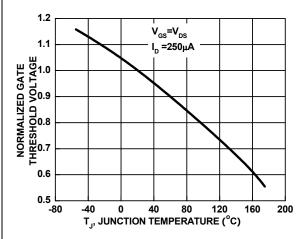


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

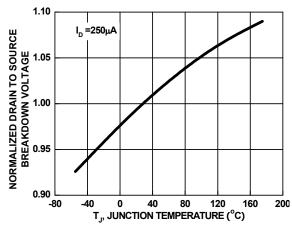


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

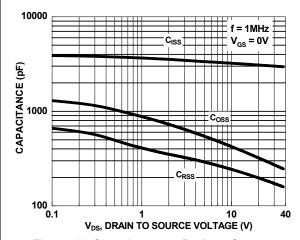


Figure 13. Capacitance vs Drain to Source Voltage

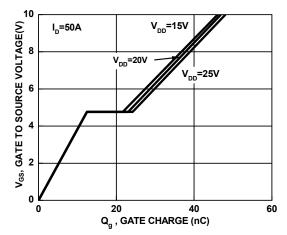
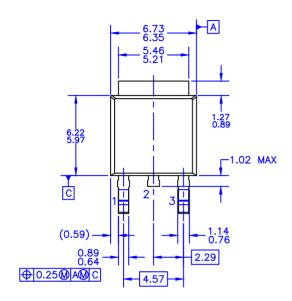
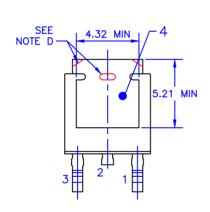
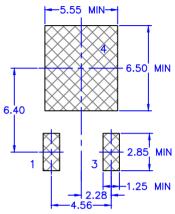
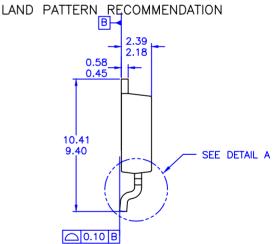


Figure 14. Gate Charge vs Gate to Source Voltage









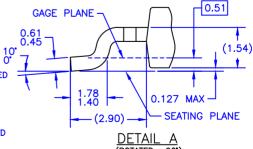
- NOTES: UNLESS OTHERWISE SPECIFIED

 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.

 B) ALL DIMENSIONS ARE IN MILLIMETERS.
 C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.

 - ASME 114.5M-2009.

 SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
 PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL. D)
 - E)
 - DIMENSIONS ARE EXCLUSSIVE OF BURSS, MOLD FLASH AND TIE BAR EXTRUSIONS. F)
 - LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD G) T0228P991X239-3N.
 - DRAWING NUMBER AND REVISION: MKT-T0252A03REV9.
 - FAIRCHILD SEMICONDUCTOR.



(ROTATED -90°) SCALE: 12X





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